Power MOSFET

60 V, 5.0 m Ω , 109 A, Single N-Channel

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFS5C658NLWF Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltag	Drain-to-Source Voltage			60	V
Gate-to-Source Voltage	Э		V _{GS}	±20	V
Continuous Drain Cur-		T _C = 25°C	I _D	109	Α
rent $R_{\theta JC}$ (Notes 1, 2, 3, 4)	Steady	T _C = 100°C		77	
Power Dissipation	State	T _C = 25°C	P_{D}	114	W
R _{θJC} (Notes 1, 2, 3)		T _C = 100°C		57	
Continuous Drain Cur-		T _A = 25°C	I _D	18	Α
rent R _{0JA} (Notes 1 & 3, 4)	Steady	T _A = 100°C		15	
Power Dissipation	State	T _A = 25°C	P_{D}	3.2	W
R _{θJA} (Notes 1, 3)		T _A = 100°C		2.2	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I _{DM}	440	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			I _S	127	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 5.0 A)			E _{AS}	142	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 3)	$R_{\theta JC}$	1.3	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	47	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi (Ψ) is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 4. Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

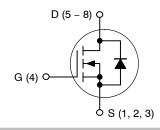


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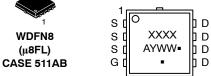
V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
60 V	5.0 m Ω @ 10 V	109 A	
60 V	7.3 m Ω @ 4.5 V	109 A	

N-Channel





MARKING DIAGRAM



XXXX = Specific Device Code = Assembly Location

= Year ww = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

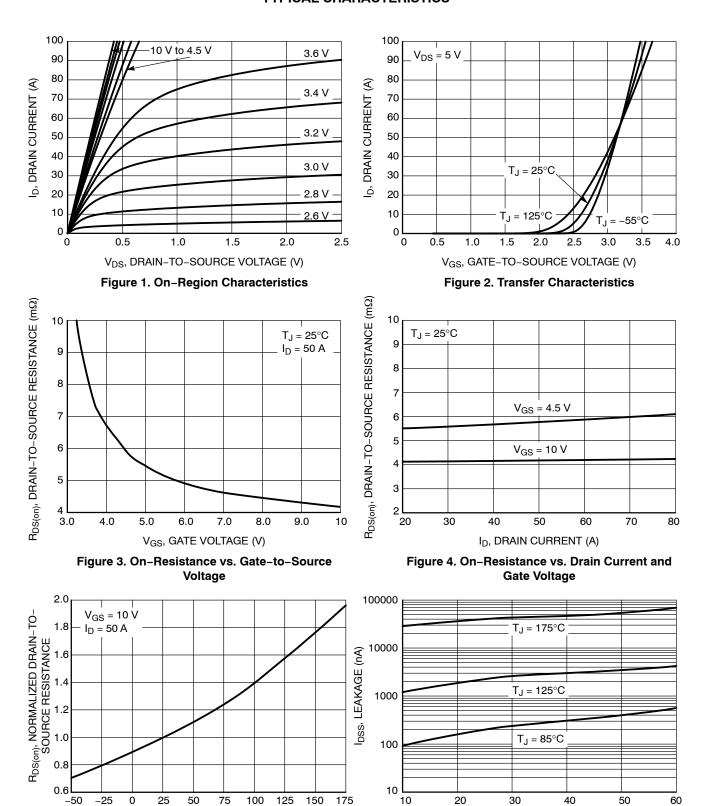
See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	-	-			-	-	-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D$	= 250 μΑ	60			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			10	μΑ
		$V_{DS} = 60 \text{ V}$	T _J = 125°C			250	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{C}$	iS = 20 V			100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{E}$) = 75 μΑ	1.2		2.2	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I	_D = 50 A		4.2	5.0	mΩ
		V _{GS} = 4.5 V,	_D = 50 A		5.8	7.3	
Forward Transconductance	9 _{FS}	V _{DS} = 15 V, I	_D = 50 A		100		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = 25 \text{ V}$			1935		pF
Output Capacitance	C _{oss}				890		
Reverse Transfer Capacitance	C _{rss}				16		1
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 48 \text{ V}, I_{D} = 50 \text{ A}$			12		nC
Threshold Gate Charge	Q _{G(TH)}				3.5		nC
Gate-to-Source Charge	Q_GS				7		
Gate-to-Drain Charge	Q_GD				2.4		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} =	48 V, I _D = 50 A		27		nC
SWITCHING CHARACTERISTICS (No	ote 6)				•	•	
Turn-On Delay Time	t _{d(on)}				16		ns
Rise Time	t _r	VGS = 4.5 V. VI	ns = 48 V.		96		
Turn-Off Delay Time	t _{d(off)}	$V_{GS} = 4.5 \text{ V, V}_{I}$ $I_{D} = 50$	Ä		36		
Fall Time	t _f				105		
DRAIN-SOURCE DIODE CHARACTEI	RISTICS						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 V$	T _J = 25°C		0.9	1.2	V
		I _S = 50 A	T _J = 125°C		0.8		
Reverse Recovery Time	t _{RR}		1		39		ns
Charge Time	t _a	V_{GS} = 0 V, dI_S/dt = 100 A/ μ s, I_S = 50 A			21		1
Discharge Time	t _b				18		1
Reverse Recovery Charge	Q_{RR}				15		nC

^{5.} Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



T_J, JUNCTION TEMPERATURE (°C)

Figure 5. On-Resistance Variation with

Temperature

V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

Figure 6. Drain-to-Source Leakage Current
vs. Voltage

TYPICAL CHARACTERISTICS

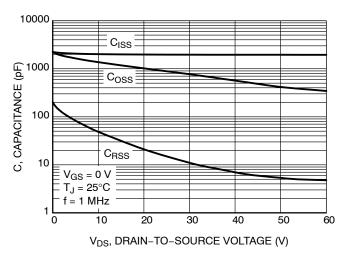


Figure 7. Capacitance Variation

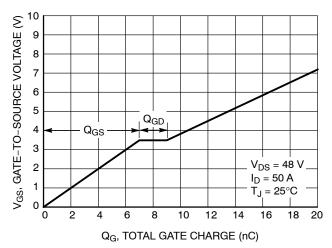


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

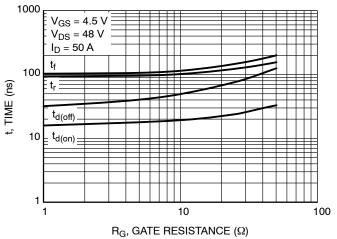


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

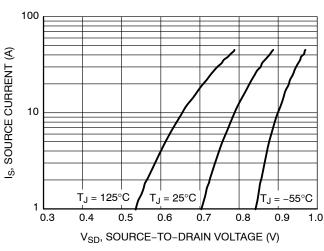


Figure 10. Diode Forward Voltage vs. Current

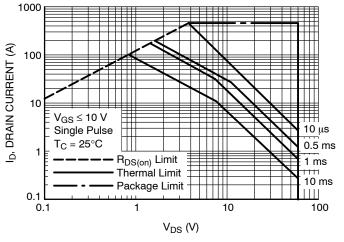


Figure 11. Maximum Rated Forward Biased Safe Operating Area

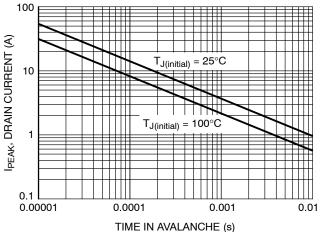


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS

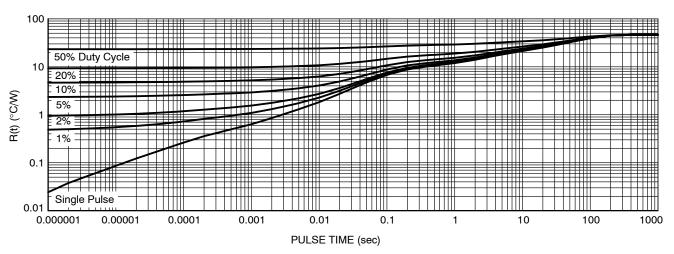


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

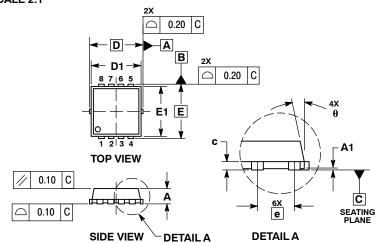
Device	Marking	Package	Shipping [†]
NVTFS5C658NLTAG	658L	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFS5C658NLWFTAG	58LW	WDFN8 (Pb-Free)	1500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

DATE 23 APR 2012



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MILLIMETERS		INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D	-	3.30 BSC	;	0	.130 BSC	
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
Е		3.30 BSC	;	0	.130 BSC)
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е	0.65 BSC		(0.026 BS	0	
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
M	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °

0.10 С A B \oplus 0.05 С E3_ D2 G-**BOTTOM VIEW**

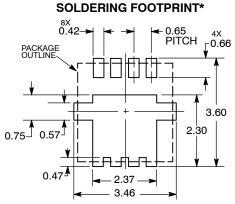
GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location Α

= Year WW = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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PAGE 2 OF 2

ISSUE	REVISION	DATE
0	RELEASED FOR PRODUCTION. REQ. BY B. MOSHER.	30 MAY 2008
Α	ADDED GENERIC MARKING INFORMATION. REQ. BY B. MOSHER.	07 AUG 2008
В	CHANGED MAX DIMENSION "B" FROM 0.41MM TO 0.40MM. REQ. BY NK THEN.	20 JAN 2009
С	ADDED DIMENSION E3. REQ. BY N. ZAINAL.	04 NOV 2011
D	CORRECTED DIMENSION K VALUES. REQ. BY D. TRUHITTE.	23 APR 2012

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